

Annex 4: Test setup photographs 22-1-0076802T12a-A4

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Product: Model:	Automotive NFC Outer Door Handle INTTAGEBTP		
FCC ID:	V2T-INTTAGEBTP	IC:	7575A-INTTAGEBTP
Testing has been carried out in accordance with:	FCC Regulations Title 47 CFR, Chapter I, Subchapter A, Part 15, Subpart C §15.225 ISED Regulations RSS-Gen, Issue 5 + Amendment 2 RSS-210, Issue 10 Deviations, modifications or clarifications (if any) to above mentioned documents are written in each section under "Test method and limit".each section under "Test method and limit".		

Table of Contents

1	Test setup photographs.....	3
	Photograph 1 : Setup for extreme temperature measurement, close up view, without NFC-Tag.....	3
	Photograph 2 : Setup for extreme temperature measurement, close up view, with NFC-Tag	3
	Photograph 3 : Setup for extreme temperature measurement, overview.....	4
	Photograph 4 : Setup in the semi anechoic chamber, measurement <30 MHz, overview, without NFC-Tag	4
	Photograph 5 : Setup in the semi anechoic chamber, measurement <30 MHz, close up view, with NFC-Tag.....	5
	Photograph 6 : Setup in the semi anechoic chamber, measurement >30 MHz, overview, with NFC-Tag.....	5
	Photograph 7 : Setup in the semi anechoic chamber, measurement >30 MHz, close up view, with NFC-Tag.....	6

Project: 22-1-0076802

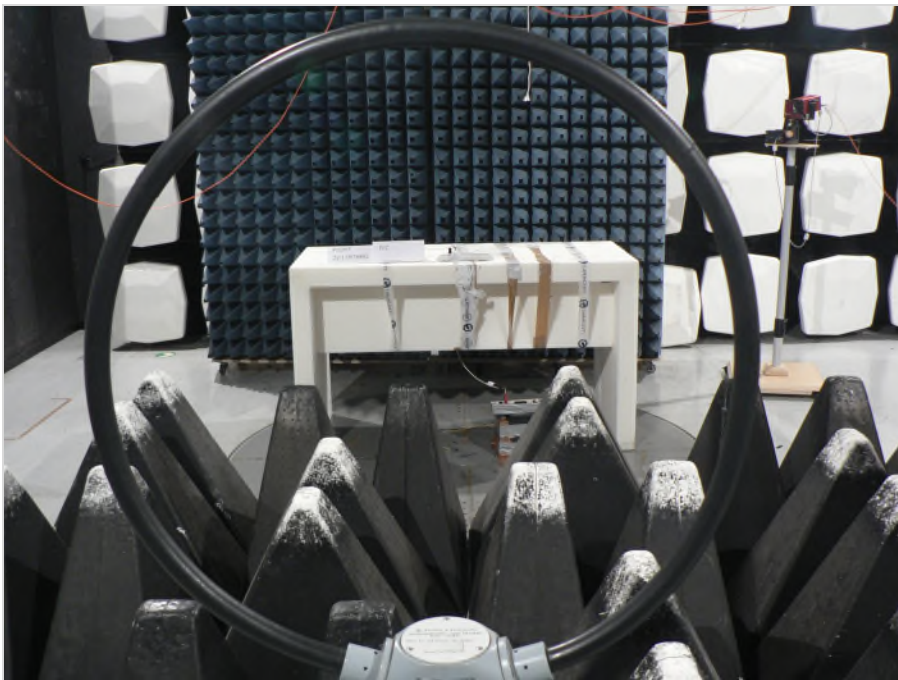
FCC

Photograph 1: Setup for extreme temperature measurement, close up view, without NFC-Tag

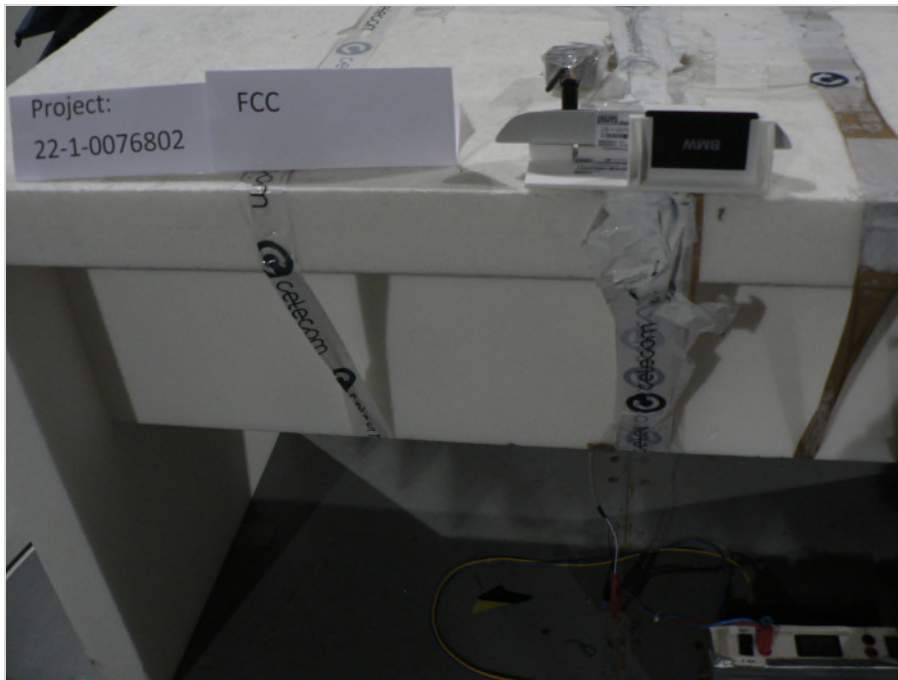




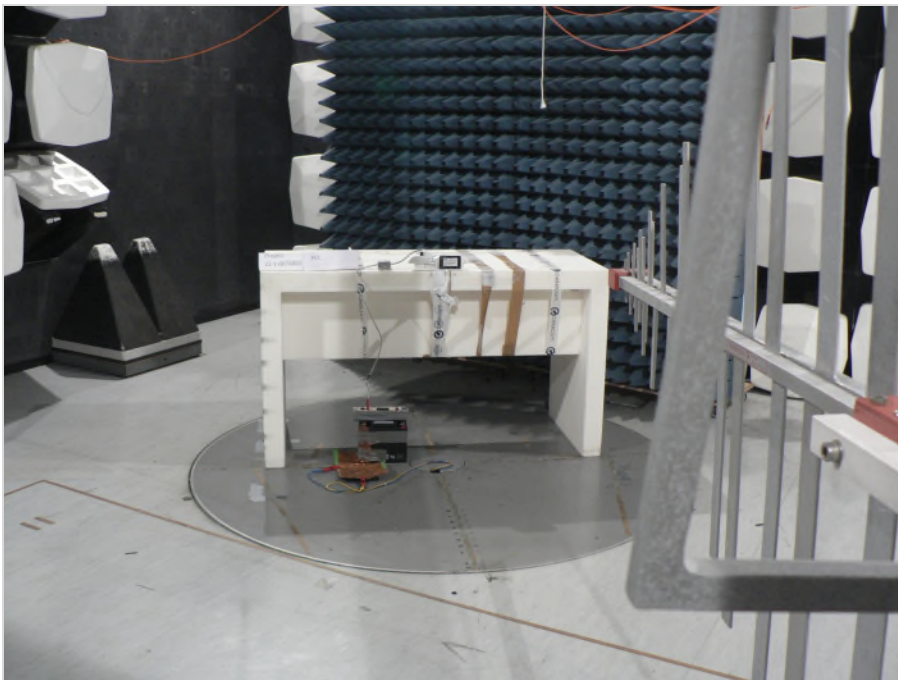
Photograph 3: Setup for extreme temperature measurement, overview



Photograph 4: Setup in the semi anechoic chamber, measurement <30 MHz, overview, without NFC-Tag



Photograph 5: Setup in the semi anechoic chamber, measurement <30 MHz, close up view, with NFC-Tag



Photograph 6: Setup in the semi anechoic chamber, measurement >30 MHz, overview, with NFC-Tag



Photograph 7: Setup in the semi anechoic chamber, measurement >30 MHz, close up view, with NFC-Tag

End Of Annex 4